## Notice of References Cited Application/Control No. 10/722,562 Examiner Jason M Han Applicant(s)/Patent Under Reexamination KAGA ET AL. Page 1 of 3

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-1,747,896	02-1930	GATES FREDERIC P	439/682
	В	US-2,949,595	08-1960	HENRY DOELEMAN	338/70
	С	US-3,887,803	06-1975	Savage, Jr., John M.	362/363
	D	US-4,033,658	07-1977	Asick, John Carl	439/218
	E	US-4,181,390	01-1980	Aizawa, Masanobu	439/375
	F	US-4,365,396	12-1982	Baba et al.	445/22
	G	US-4,644,452	02-1987	Kasboske, George C.	362/214
	H	US-4,758,181	07-1988	Reedy, Patrick J.	439/546
	ı	US-4,883,434	11-1989	Toyoshima, Akira	439/619
	J	US-4,894,027	01-1990	Brantingham et al.	439/699.2
	К	US-4,902,251	02-1990	Grzena, Karl R.	439/699.2
	L	US-4,959,761	09-1990	Critelli et al.	362/226
	М	US-4,968,270	11-1990	Colleran et al.	439/699.2

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2001-110210	04-2001	Japan	Tsukamoto et al.	F21W101:02
	0	04-026087	01-1992	Japan	Tsuji Ryoji	H01R 33/46
	Ρ					
	α					
	R					
	S					
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### **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | KAGA ET AL. | Examiner | Art Unit | Page 2 of 3

#### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,008,588	04-1991	Nakahara, Toshiro	313/318.1
	В	US-5,080,615	01-1992	Kondo, Hiroyuki	439/699.2
	С	US-5,222,803	06-1993	Kraus, Willibald	362/226
	D	US-5,368,503	11-1994	Savage, Jr., John M.	439/502
	E	US-5,427,532	06-1995	Owen et al.	439/57
	F	US-5,558,543	09-1996	Takano et al.	439/699.2
	G	US-5,578,893	11-1996	Yamamoto, Teruaki	313/112
	Н	US-5,630,729	05-1997	Francis, Michael E.	439/548
	ı	US-5,634,823	06-1997	Furuta et al.	439/699.2
	J	US-5,709,571	01-1998	Briski et al.	439/699.2
	К	US-5,847,512	12-1998	Baba et al.	315/51
	L	US-6,120,312	09-2000	Shu, Kuo Fen	439/356
	М	US-6,152,568	11-2000	Baba et al.	362/23

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
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## **NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

## Notice of References Cited Application/Control No. 10/722,562 Examiner Jason M Han Applicant(s)/Patent Under Reexamination KAGA ET AL. Art Unit Page 3 of 3

### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,406,173	06-2002	Serizawa et al.	362/545
	В	US-2003/0058658	03-2003	Lee, Han-Ming	362/555
	С	US-6,570,308	05-2003	Helbig et al.	313/318.09
	D	US-2003/0142508	07-2003	Lee, Han-Ming	362/555
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
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## **FOREIGN PATENT DOCUMENTS**

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## NON-PATENT DOCUMENTS

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.